

#### **PART NUMBER**

#### COMPONENT SPECIFICATION



# Component Specification For Hermetically Sealed, Radiation-Hard Transistor Optocouplers

Features	Applications
<ul> <li>Hermetically Sealed</li> <li>Radiation Tolerant tested to 150 Krad(si)</li> <li>High Isolation up to 1,000V<sub>DC</sub></li> <li>LCC-6 Package</li> <li>Low Input Requirements</li> <li>High Current Transfer Ratio</li> </ul>	<ul> <li>Space Equipment and Systems</li> <li>Military and High Reliability Systems</li> <li>Medical Instruments</li> <li>MOS/CMOS Applications</li> <li>Logic Interfacing</li> <li>Data Transmission</li> <li>Power Supply</li> <li>Modems</li> </ul>

#### DESCRIPTION

This device is a single channel, hermetically sealed optically coupled isolator. It is composed of a Gallium Arsenide infrared emitting diode and a silicon phototransistor.

The CSM1224 series is being used in environments encountered by space applications. Package styles for this device include an LCC-6 package, with solder dip option available.

Absolute maximum ratings, recommended operating conditions, electrical specifications and performance characteristics are identical for all units. Any exceptions, due to packaging variations and limitations, are as note









ISOCOM Limited is AS9100 certified for the design and manufacture of electronic and optoelectronic components.

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#### **STANDARDS**

The following specifications have been complied with in the manufacturing of this product -

#### Aerospace Compliance Standards

AS9100D & ISO 9001:2015 - Design & Manufacture of Electronic and Optoelectronic Components (Ref GB15/92780)

#### Military Compliance Specifications

MIL-PRF-38534 – General Specification for Hybrid Microcircuits
MIL-PRF-19500 – General Specification for Discrete Semiconductor Devices

#### Military Compliance Standards

MIL-STD-202 - Test Method Standard Electronic and Electrical Component Parts

MIL-STD-883 - Test Method Standard Microcircuits

MIL-STD-750 - Test Method Standard for Semiconductor Devices

#### **SCREENING INFORMATION**

Our products can be screened to MIL-PRF-38534, applying test methods from MIL-STD-883; MIL-PRF-19500, applying test methods of MIL-STD-750; or a combination thereof. Please contact us for more information relating to the applicable screening processes.

#### AMENDMENT RECORD

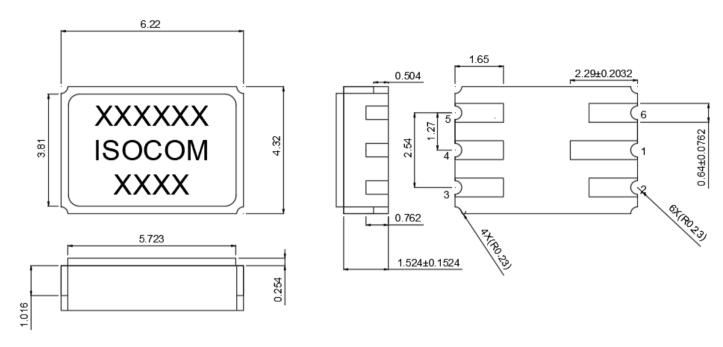
Issue No.	Date	Description	
1	August 2013	First issue	
2	September 2020	Updated Quality Management Logos and removed IECQ Logos	
3	May 2022	Added Radiation Testing and Electrical Testing Diagrams, Added Render	
4	June 2022	Updated Electrical Characteristics Graphs and Added Screening Flow	
5	November 2022	Updated Format	
6	August 2023	Added pin configuration, updated screening, updated circuit drawings and device marking	

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## **OUTLINE DRAWING**



#### PACKAGE STYLES AND CONFIGURATION OPTIONS

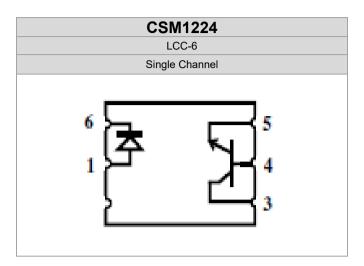
Package	6-Pin LCC
Lead Style	-
Channels	1
Common Channel Wiring	-
Isocom Part Number and O	ptions
Commercial	CSM1224
Defense Screen Level	CSM1224/L2
Space Screen Level	CSM1224/L2S
Standard Gold Plate Finish	Gold Plate
Butt Joint	_
Solder Dipped	Option 20
Gull Wing	_
Butt Joint	_

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## **FUNCTIONAL DIAGRAMS**



#### PIN OUT INFORMATION

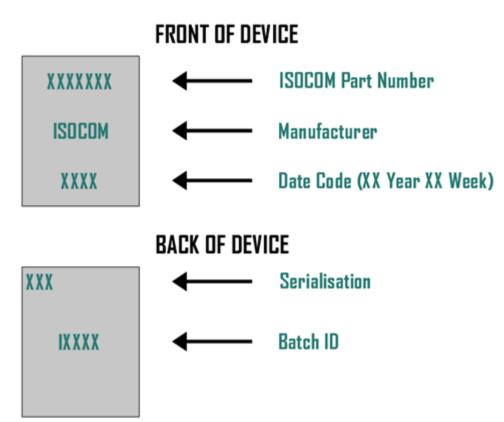
Pin Number	Pin Function
1	LED Anode
2	N/C
3	Collector
4	Base
5	Emitter
6	LED Cathode

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#### **DEVICE MARKING**



\*FOR SPACE SCREENED PARTS ONLY\*

#### **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25$ °C C.U.O.S

Storage Temperature	-65°C to +150°C	
Operating Temperature	-55°C to +125°C	
Lead Soldering Temperature	260°C 1.6mm from case for 10s	
Input-to-Output Isolation Voltage	û1,000V <sub>DC</sub>	
Input Diode		
Average Forward Current	50mA	
Reverse Voltage	7V	
Peak forward Current	1.5A	
Power Dissipation	100mW	
<b>Output Transistor</b>		
Supply Voltage	0.5V to 20V	
Average Current	8mA	
Collector Current	50mA	
Power Dissipation	150Mw	

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#### **ELECTRICAL CHARACTERISTICS**

 $T_A = -55^{\circ}C - 125^{\circ}C \text{ U.O.S.}$ 

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Input Diode Electric	al Characte	eristics				
Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 10mA	0.7	1.2	1.8	V
Reverse Current	I <sub>R</sub>	V <sub>R</sub> = 3.0V	-	-	100	μA
Output Detector Ele	ctrical Cha	racteristics	<u> </u>			
Collector-Emitter Breakdown Voltage	V <sub>(BR)CEO</sub>	I <sub>C</sub> = 0.1mA	70	100	-	V
Collector-Base Breakdown Voltage	V <sub>(BR)CBO</sub>	I <sub>B</sub> = 100μA	70	200	-	V
Emitter-Collector Breakdown Voltage	V <sub>(BR)ECO</sub>	I <sub>E</sub> = 0.1mA	7	9	-	V
Emitter-Base Breakdown Voltage	V <sub>(BR)EBO</sub>	I <sub>B</sub> = 1mA	5	-	-	V
Collector–Emitter Leakage Current	I <sub>CEO</sub>	V <sub>CE</sub> = 20V, I <sub>F</sub> = 0A	-	7	100	μA
Coupled Electrical C	haracteris	tics				
		I <sub>F</sub> = 1.0mA, V <sub>CE</sub> = 1V	200	-	-	%
	l <sub>C/</sub> l <sub>F</sub>	$I_F = 3.0 \text{mA}, V_{CE} = 1 \text{V}$	200	-	-	%
DC Current Transfer Ratio		I <sub>F</sub> = 15.0mA, V <sub>CE</sub> = 1V	100	-	-	%
(Pre-Radiation)		I <sub>F</sub> = 10.0mA, V <sub>CE</sub> = 5V	350	-	-	%
		I <sub>F</sub> = 15.0mA, V <sub>CE</sub> = 5V	100	-	-	%
		I <sub>F</sub> = 1.0mA, V <sub>CE</sub> = 15V	300			%
Collector-Emitter Saturation Voltage	V <sub>CE(Sat)</sub>	I <sub>C</sub> = 10.0 mA I <sub>F</sub> = 20 mA	-	-	0.22	V
Isolation Voltage (1)	V in-out	T = 5s	1,500	-	-	V <sub>DC</sub>
Input to Output Resistance (1)	R in-out	V <sub>IO</sub> = 500V	-	10 <sup>11</sup>		Ω
Rise Time	t <sub>r</sub>	$R_L = 100\Omega$ , $V_{CC} = 10V$ , $I_F = 10mA$	-	6	12	μs
Fall Time	t <sub>f</sub>	$R_L = 100\Omega, V_{CC} = 10V, I_F = 10mA$	-	6	12	μs
Propagation Delay – H-L	t <sub>PHL</sub>	$R_L = 100\Omega, V_{CC} = 10V, I_F = 10mA$	-	-	5.0	μs
Propagation Delay – L-H	t <sub>PLH</sub>	$R_L = 100\Omega$ , $V_{CC} = 10V$ , $I_F = 10mA$	-	-	5.0	μs
		I <sub>F</sub> = 1.0mA, V <sub>CE</sub> = 1V	200	-	-	%
		I <sub>F</sub> = 3.0mA, V <sub>CE</sub> = 1V	100	-	-	%
DC Current Transfer Ratio		I <sub>F</sub> = 15.0mA, V <sub>CE</sub> = 1V	66	-	-	%
(Post-Radiation)	I <sub>C</sub> /I <sub>F</sub>	I <sub>F</sub> = 10.0mA, V <sub>CE</sub> = 5V	160	-	-	%
		I <sub>F</sub> = 15.0mA, V <sub>CE</sub> = 5V	40	-	-	%
		I <sub>F</sub> = 1.0mA, V <sub>CE</sub> = 15V	250	-	-	%

#### Notes:

1. Measurements with inputs shorted together and outputs shorted together.

## **ELECTRICAL CHARACTERISTICS**

Typical Graphs - Contact Office for more information

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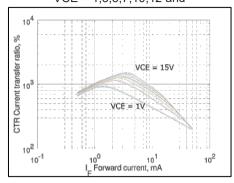
1.4

1.2

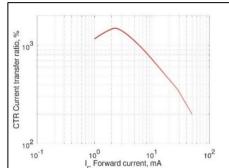
0.8

10<sup>-1</sup>

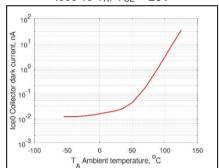
VCE = 1,3,5,7,10,12 and



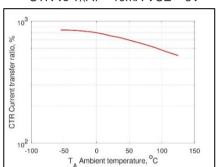
CTR vs I<sub>F</sub>: V<sub>CE</sub> = 5V T<sub>A</sub> = 25°C



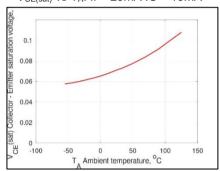
Iceo vs T<sub>A</sub>: V<sub>CE</sub> = 20V



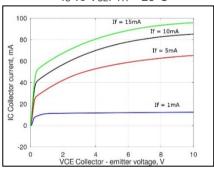
10<sup>0</sup> 10<sup>1</sup> \_ Forward current, mA CTR vs T<sub>A</sub>: If = 10mA VCE = 5V



 $V_{CE(sat)}$  vs  $T_A$ : If = 20mA IC = 10mA





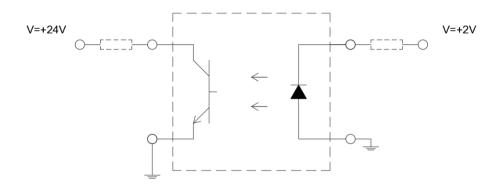


#### HTRB TEST CIRCUIT

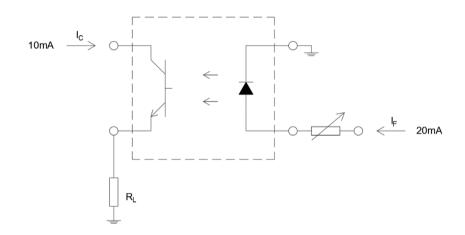
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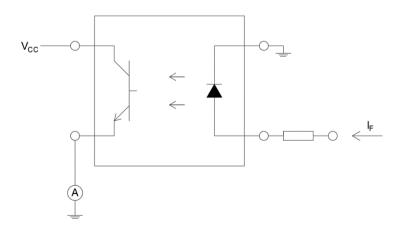




#### **ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS**



## **ELECTRICAL MEASUREMENT OF COLLECTOR CURRENT**

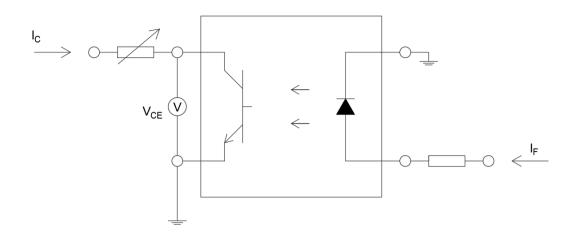


## ELECTRICAL MEASUREMENT OF COLLECTOR EMITTER SATURATION VOLTAGE

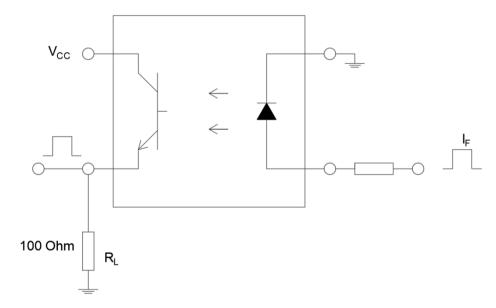
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## **ELECTRICAL MEASUREMENT OF A.C PARAMETERS**

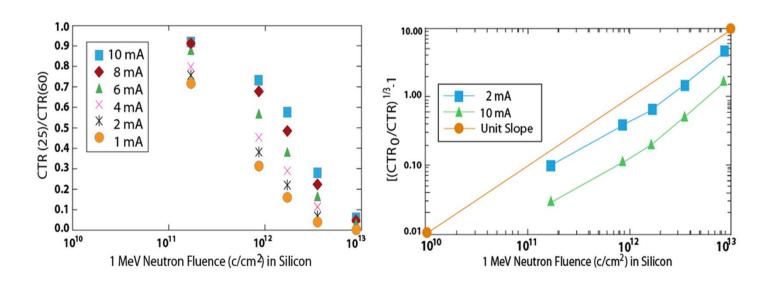


## **SWITCHING TIME**





## **RADIATION TESTING**

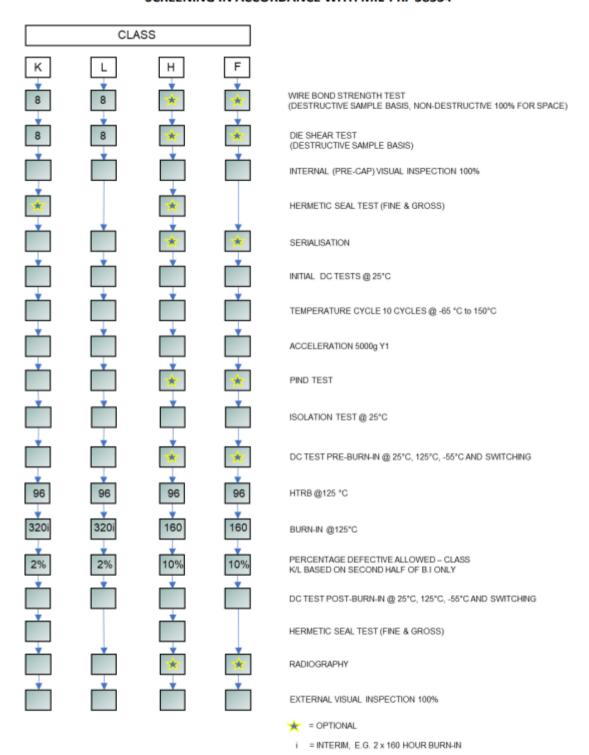


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#### **SCREENING IN ACCORDANCE WITH MIL-PRF 38534**



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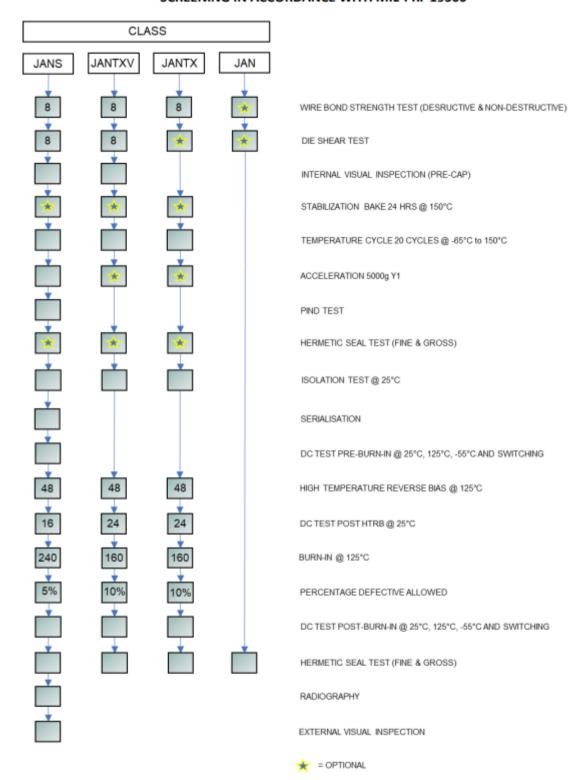


The following screening flow includes the electrical tests between each screening step, the referenced test method from MIL-STD 883 and the sample basis for Class K/L and H/F quality levels.

New Content	Operation No Operation		, MIL-STD 883 TEST METHOD	Class		
2   Wile bond strength (D)	Operation No.	Operation	MIL-31D 863 TEST METHOD	H/F (L2)	K/L (L28)	
Box   Bear   Box	1	Wire bond strength (ND)	(883) 2023	Optional	100%	
Internal Visual (883) 2017   100%   100%   100%   100%   5   Fine Isaak, Helkum bornb, Lauk detector (883) 1014, Con A1   Optional Optio	2	Wire bond strength (D)	(883) 2011	Optional	8 devices	
\$ Fine leak, Helkum bomb, Leak detector (883) 1014, Con A1 Optional Optional Gross leak, Liquid bomb, -Bubble chamber (883) 1014, Con C1 Optional O	3	Die Shear	(883) 2019	Optional	8 devices	
6 Gioss leak, Liquid bomb, -Bubble chamber (883) 1014, Con C1 Optional Optional 7 Serialisation of devices Optional 100% 100% 100% 100% 100% 100% 100% 100	4	Internal Visual	(883) 2017	100%	100%	
Sentalisation of devices	5	Fine leak, Helium bomb, Leak detector	(883) 1014, Con A1	Optional	Optional	
B	6	Gross leak, Liquid bomb, -Bubble chamber	(883) 1014, Con C1	Optional	Optional	
Temp cycle @-65°C to 150°C (883) 1010, Con C, 10 cycles 100% 100% 100% 100% 100% 100% 100% 100	7	Serialisation of devices		Optional	100%	
10   Electrical Test 25°C	8	Electrical Test 25°C		100%	100%	
11	9	Temp cycle @ -65°C to 150°C	(883) 1010, Con C, 10 cycles	100%	100%	
12 Electrical Test 25°C 100% 100% 100% 100% 100% 100% 100% 100	10	Electrical Test 25°C		100%	100%	
13 P.I.N.D (883) 2020, Con A. Optional 100% 14 Electrical Test 25°C 100% 15 Isolation 100% @ 25°C (MIL-STD 202) 301 100% 100% 16 Electrical Test 25°C 100% 17 Electrical Test 25°C Optional 100% 18 Electrical Test 25°C Optional 100% 19 Switching time 100% @ 25°C Optional 100% 20 HTRB @ 125°C - 96 hrs (883) 1015, con A 100% 100% 21 Electrical Test 25°C (883) 1015, con B 100% 22 Burn in @ 125°C (883) 1015, con B 100% 23 Electrical Test 25°C (883) 1015, con B N/A 160 hrss 24 Burn in @ 125°C (883) 1015, con B N/A 160 hrss 25 Percentage defective allowable Prelipost Burn-in electrical and delta at 25°C only Max. 10% Max. 2% 26 Electrical Test 25°C Group A - 8G1 100% 100% 27 Electrical Test 25°C Group A - 8G2 100% 100% 28 Electrical Test 25°C Group A - 8G2 100% 100% 29 Switching time 100% @ 25°C Group A - 8G3 100% 100% 30 Fine leak, Helium bomb, Leak detector (883) 1014, Con C1 100% 100% 31 Gross leak, Liquid bomb, -Bubble chamber (883) 1014, Con C1 100% 100%	11	Constant acceleration	(883) 2001, 3000g, Y1	100%	100%	
14   Electrical Test 25°C   (MIL-STD 202) 301   100%   1	12	Electrical Test 25°C		100%	100%	
15	13	P.J.N.D	(883) 2020, Con A	Optional	100%	
16	14	Electrical Test 25°C		100%	100%	
17 Electrical Test 125°C Optional 100% 18 Electrical Test -55°C Optional 100% 19 Switching time 100% @ 25°C Optional 100% 20 HTRB @ 125°C - 96 hrs (883) 1015, con A 100% 100% 21 Electrical Test 25°C 100% 22 Burn in @ 125°C (883) 1015, con B 100% 23 Electrical Test 25°C 100% 24 Burn in @ 125°C (883) 1015, con B 100% 25 Percentage defective allowable Pre/post Burn-in electrical and delta at 25°C only Max. 10% Max. 2% 26 Electrical Test 25°C Group A - 9G1 100% 100% 27 Electrical Test 25°C Group A - 9G1 100% 100% 28 Electrical Test -55°C Group A - 9G3 100% 100% 30 Fine leak, Heilum bomb, Leak detector (883) 1014, Con C1 100% 100% 31 Gross leak, Liquid bomb, -Bubble chamber (883) 1014, Con C1 100% 100%	15	Isolation 100% @ 25°C	(MIL-STD 202) 301	100%	100%	
B	16	Electrical Test 25°C		100%	100%	
19 Switching time 100% @ 25°C  100%  100%  100%  20 HTRB @ 125°C - 96 hrs  Electrical Test 25°C  100%	17	Electrical Test 125°C		Optional	100%	
20 HTRB @ 125°C - 96 hrs (883) 1015, con A 100% 100% 21 Electrical Test 25°C (883) 1015, con B 100% 100% 100% 100% 100% 100% 100% 10	18	Electrical Test -55°C		Optional	100%	
Electrical Test 25°C   100%   100%   100%   100%   100%   100%   100%   100%   100%   100%   160 hrs   1	19	Switching time 100% @ 25°C		Optional	100%	
Burn in @ 125°C   (883) 1015, con B   100% 160 hours   100% 160 hrs   100% 160	20	HTRB @ 125°C - 96 hrs	(883) 1015, con A	100%	100%	
Burn in @ 125°C   (883) 1015, con B   160 hours   16	21	Electrical Test 25°C		100%	100%	
24         Burn in @ 125°C         (883) 1015, con B         N/A         100% 160 hrs           25         Percentage defective allowable         Pre/post Burn-in electrical and delta at 25°C only         Max. 10%         Max. 2%           26         Electrical Test 25°C         Group A - SG1         100%         100%           27         Electrical Test 125°C         Group A - SG2         100%         100%           28         Electrical Test -55°C         Group A - SG3         100%         100%           29         Switching time 100% @ 25°C         Group A - SG9         100%         100%           30         Fine leak, Helium bomb, Leak detector         (883) 1014, Con A1         100%         100%           31         Gross leak, Liquid bomb, -Bubble chamber         (883) 1014, Con C1         100%         100%           32         Radiography         (883) 2012         Optional         100%	22	Burn in @ 125°C	(883) 1015, con B			
25 Percentage defective allowable Pre/post Burn-in electrical and delta at 25°C only Max. 10% Max. 2%  26 Electrical Test 25°C Group A - SG1 100% 100%  27 Electrical Test 125°C Group A - SG2 100% 100%  28 Electrical Test -55°C Group A - SG3 100% 100%  29 Switching time 100% @ 25°C Group A - SG9 100% 100%  30 Fine leak, Helium bomb, Leak detector (883) 1014, Con A1 100% 100%  31 Gross leak, Liquid bomb, -Bubble chamber (883) 1014, Con C1 100% 100%  32 Radiography (883) 2012 Optional 100%	23	Electrical Test 25°C		100%	100%	
26         Electrical Test 25°C         Group A - SG1         100%         100%           27         Electrical Test 125°C         Group A - SG2         100%         100%           28         Electrical Test -55°C         Group A - SG3         100%         100%           29         Switching time 100% @ 25°C         Group A - SG9         100%         100%           30         Fine leak, Helium bomb, Leak detector         (883) 1014, Con A1         100%         100%           31         Gross leak, Liquid bomb, -Bubble chamber         (883) 1014, Con C1         100%         100%           32         Radiography         (883) 2012         Optional         100%	24	Burn in @ 125°C	(883) 1015, con B	N/A	100% 160 hrs	
27         Electrical Test 125°C         Group A - SG2         100%         100%           28         Electrical Test -55°C         Group A - SG3         100%         100%           29         Switching time 100% @ 25°C         Group A - SG9         100%         100%           30         Fine leak, Helium bomb, Leak detector         (883) 1014, Con A1         100%         100%           31         Gross leak, Liquid bomb, -Bubble chamber         (883) 1014, Con C1         100%         100%           32         Radiography         (883) 2012         Optional         100%	25	Percentage defective allowable	Pre/post Burn-in electrical and delta at 25°C only	Max. 10%	Max. 2%	
28         Electrical Test -55°C         Group A - 9G3         100%         100%           29         Switching time 100% @ 25°C         Group A - 9G9         100%         100%           30         Fine leak, Helium bomb, Leak detector         (883) 1014, Con A1         100%         100%           31         Gross leak, Liquid bomb, -Bubble chamber         (883) 1014, Con C1         100%         100%           32         Radiography         (883) 2012         Optional         100%	26	Electrical Test 25°C	Group A - 9G1	100%	100%	
29     Switching time 100% @ 25°C     Group A - SG9     100%     100%       30     Fine leak, Helium bomb, Leak detector     (883) 1014, Con A1     100%     100%       31     Gross leak, Liquid bomb, -Bubble chamber     (883) 1014, Con C1     100%     100%       32     Radiography     (883) 2012     Optional     100%	27	Electrical Test 125°C	Group A - SG2	100%	100%	
30         Fine leak, Helium bomb, Leak detector         (883) 1014, Con A1         100%         100%           31         Gross leak, Liquid bomb, -Bubble chamber         (883) 1014, Con C1         100%         100%           32         Radiography         (883) 2012         Optional         100%	28	Electrical Test -55°C	Group A - 9G3	100%	100%	
31         Gross leak, Liquid bomb, -Bubble chamber         (883) 1014, Con C1         100%         100%           32         Radiography         (883) 2012         Optional         100%	29	Switching time 100% @ 25°C	Group A - 9G9	100%	100%	
32 Radiography (883) 2012 Optional 100%	30	Fine leak, Helium bomb, Leak detector	(883) 1014, Con A1	100%	100%	
	31	Gross leak, Liquid bomb, -Bubble chamber	(883) 1014, Con C1	100%	100%	
33 External Visual (883) 2009 100% 100%	32	Radiography	(883) 2012	Optional	100%	
	33	External Visual	(883) 2009	100%	100%	



#### SCREENING IN ACCORDANCE WITH MIL-PRF 19500



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The following screening flow includes the electrical tests between each screening step, the referenced test method from MIL-STD 750 and the sample basis for Class JANTX, JANTXV and JANS quality levels.

Operation				Class			
No.	Operation	MIL-PRF 19500	JANTX (L2)	JANTXV (L2)	JANS (L2S)		
1	Wire bond strength (ND)	(883) 2023	100%	100%	100%		
2	Wire bond strength (D)	(750) 2037, Con D	4 devices	4 devices	8 devices		
3	Die Shear	(750) 2017	4 devices	4 devices	8 devices		
4	Internal Visual	(750) 2072	Optional	100%	100%		
5	Stabilization Bake		Optional	Optional	Optional		
6	Electrical Test @ 25°C		100%	100%	100%		
7	Temp cycle (20 cycles @ -65°C to 150°C)	(750) 1051, Con F	100%	100%	100%		
8	Electrical Test @ 25°C		100%	100%	100%		
9	Constant acceleration	(750) 2006, 5000g, Y1	Optional	Optional	100%		
10	Electrical Test @ 25°C		100%	100%	100%		
11	P.I.N.D	(750) 2052, Con A	N/A	N/A	100%		
12	Electrical Test @ 25°C		N/A	N/A	100%		
13	Fine leak, Helium bomb, -Leak detector	(750) 1071 Con H1	Optional	Optional	Optional		
14	Gross leak, Liquid bomb, Bubble chamber	(750) 1071, Con C	Optional	Optional	Optional		
15	Serialisation of devices		N/A	N/A	100%		
16	Isolation 100% @ 25°C	(MIL-STD 202) 301	100%	100%	100%		
17	Electrical Test @ 25°C		100%	100%	100%		
18	Electrical Test @ 125°C		100%	100%	100%		
19	Electrical Test @ -55°C		100%	100%	100%		
20	Switching time @ 25°C		100%	100%	100%		
21	HTRB (125°C)	(750) 1039, Con A (80% VDS)	100% (48 hrs)	100% (48 hrs)	100% (48 hrs)		
22	Electrical Test @ 25°C		100% (24 hrs)	100% (24 hrs)	100% (16 hrs)		
23	Burn-In (125°C)	(750) 1039, Con B (80% VDS)	100% (160 hrs)	100% (160 hrs)	100% (240 hrs)		
24	Percentage defective allowable	Pre/post Burn-in electrical and delta at 25°C only	100% @ 10% PDA	100% @ 10% PDA	100% @ 5% PDA		
25	Electrical Test @ 25°C		100% (Group A, SG 2)	100% (Group A, SG 2)	100% (Group A, SG 2)		
26	Electrical Test @ 125°C		100% (Group A, SG 3)	100% (Group A, SG 3)	100% (Group A, SG 3)		
27	Electrical Test @ -55°C		100% (Group A, SG 3)	100% (Group A, SG 3)	100% (Group A, SG 3)		
28	Switching time @ 25°C		100% (Group A, SG4)	100% (Group A, SG4)	100% (Group A, SG4)		
29	Fine leak, Helium bomb, -Leak detector	(750) 1071 Con H1	100%	100%	100%		
30	Gross leak, Liquid bomb, Bubble chamber	(750) 1071, Con C	100%	100%	100%		
31	Radiography	(750) 2076	N/A	N/A	100%		
32	External Visual	(750) 2071	N/A	N/A	100%		



## MIL-PRF 19500 TYPICAL QCI TESTING PROCESS FLOW

Group	Sub	Parameters	Quantity (accept number)			
Group	Group	rarameters	TM	JANS	JANTX, JANTXV	
	1	Visual and mechanical inspection	750-2071		100%	
A (CI)	2	Static tests at +25°C	Datasheet	100%		
A (CI)	3	Static tests at min and max. rated operating temp.	Datasheet	100%	10076	
	4	Dynamic test at +25°C	Datasheet			
		(JANS)		Large LOT (accept)	Small LOT (accept)	
	1	Physical dimension	750-2066	22 (0)	8 (0)	
	2	Solderability	750-2026	15 leads (0)	6 leads (0)	
		Temperature cycling (100 cycles)	750-1051			
		Hermetic seal (fine and gross leak)	750-1071	22 (0)	6 (0)	
		Electrical measurements	GRP-A- SG2	(0)	5(5)	
B (PI)	3	Decap internal visual	750-2075	6 (0)	6 (0)	
5,.,		Bond strength	750-2037	22 wires (0) or 11 (0)	12 wires (0) or 6 (0)	
		SEM	750-2077	11 (0)	6 (0)	
		Die shear	750-2017	11 (0)	6 (0)	
		Intermittent operation life (2000 cycles)	750-1037			
	4	Electrical measurements S		22 (0)	12 (0)	
		(JANTXV, JANTX)		Large LOT (accept)	Small LOT (accept)	
	1	Solderability	750-2026	15 leads (0)	4 leads (0)	
		Temperature cycling (45 cycles incl. screening)	750-1051			
	2	Hermetic Seal (fine and gross leak)	750-1071	22 (0)	6 (0)	
		Electrical measurements	GRP-A-	• •		
D (DI)			SG2			
B (PI)		Steady state op. life (340 Hrs) or	750-1026 or 750-			
	3	intermittent op. life (2000 cycles)	or 750-	45 (0)	12 (0)	
	3	Electrical measurements	GRP-A- SG2	40 (0)	12 (0)	
	4	Decap internal visual	750-2075	1 (0)	1 (0)	



#### MIL-PRF 19500 TYPICAL QCI TESTING PROCESS FLOW

Group	Sub Group	Parameters	ТМ	Sample plan	Small LOT (accept)	
	1	Physical dimensions (Not Req. JANS)	750-2066	15 (0)	6 (0)	
		Thermal shock (25 cycles, con B)	750-1056			
		Temperature cycling (45 cycles incl. screening)	750-1051			
	2	Terminal strength	750-2036	22 (0)	6 (0)	
		Hermetic seal (fine and gross leak)	750-1071	22 (0)	0 (0)	
	C (PI)	Electrical measurements	GRP-A-			
		Liettitai measurements	SG2			
C (PI)		Constant acceleration (5000g, Y1 only)	750-2006	22 (0)	6 (0)	
	3	3 Electrical measurements	GRP-A-			
		Erostour frederictions	SG2			
		Steady state op. life (1000 Hrs) or	750-1026			
	6	intermittent op. life (6000 cycles)	or 750-			
		6 Electrical measurements	1037	22 (0)	12 (0)	
			GRP-A-			
			SG2	0.40	0 (0)	
	7	Internal Gas Analysis - Moisture 10,000 ppmv limit	750-1018	3 (0)	3 (0)	



## MIL-PRF 38534 TYPICAL QCI TESTING PROCESS FLOW

Group	Sub Group	. Parameters	Quantity (accept number)			
Стоир	Sub Group	Farameters	TM	К	н	
	1	Static tests at +25°C	Datasheet	100%	100%	
A (CI)	2	Static tests at max. rated operating temp.	Datasheet	100%	100%	
A (CI)	3	Static tests at min. rated operating temp.	Datasheet	100%	100%	
	9	Switching tests at +25°C	Datasheet	100%	100%	
	1	Physical dimension	883-2016	2 (0)	2 (0)	
	4	Internal visual and mechanical	883-2014	1 (0)	1 (0)	
B (PI)	5	Bond strength: Ultrasonic (on hotplate)	883-2011	2 (0)	2 (0)	
5 (,	6	Die shear strength	883-2019	2 (0)	2 (0)	
	7	Solderability	883-2003	1 (0)	1 (0)	
	8	Seal: a. Fine, b. Gross	883-1014	N/A	15 (0)	
		External visual	883-2009	5 (0)	5 (0)	
		Temperature Cycling	883-1010	5 (0)	5 (0)	
		Constant acceleration	883-2001	X	5 (0)	
	1	Seal (fine and gross)	883-1014	5 (0)	5 (0)	
		PIND	883-2020	5 (0)	5 (0)	
C (PI)		Visual examination	883-1010	5 (0)	5 (0)	
		End-point electrical	GRP-A	5 (0)	5 (0)	
	2	Steady-state life test	883-1005	22 (0) or 5 (0)	22 (0) or 5 (0)	
		End-point electrical	GRP-A	22 (0) or 5 (0)	22 (0) or 5 (0)	
	3	Internal gas analysis	883-1018	2 (0) or E (1)	3 (0) or E (1)	
	3	Moisture 10,000 ppmv limit	003-1010	3 (0) or 5 (1)	3 (0) or 5 (1)	
		Thermal shock	883-1011	5 (0)	5 (0)	
D (PI)	1	Stabilization bake	883-1008	5 (0)	5 (0)	
		Lead integrity	883-2004	1 (0)	1 (0)	
		Seal: a. Fine, b. Gross	883-1014	5 (0)	5 (0)	

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#### Summary of key differences between MIL-PRF 19500 and MIL-PRF 38534 for space level testing:

	MIL-PRF 19500 - JANS	MIL-PRF 38534 – Class K		
No. of Operation	31	33		
(Screening) Steps	٥.	55		
Optional				
Hermeticity	Occurs post P.I.N.D	Occurs post Internal Visual		
Testing				
Temp cycle – No.	20	10		
of Temp Cycles				
Acceleration -	5000g	3000g		
Amount of g force				
HTRB – No. of	48	96		
hours				
Burn-in – No. of	240 hrs in one successive burn-in	320 hrs (2 x 160 hrs with interim electrical)		
hours				
PDA post burn-in	5% after 240 hrs burn-in	2% after second 160 hrs burn-in		



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ISOCOM Limited is AS9100 certified for the design and manufacture of electronic and optoelectronic components.

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